



60V N+P Dual Channel MOSFETs

General Description

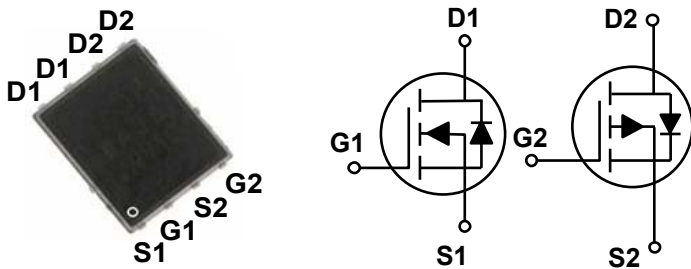
These N+P dual Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BV_{DSS}	R_{DS(ON)}	I_D
60 V	40 mΩ	6.06 A
-60 V	70 mΩ	-4.58 A

Features

- Fast switching
- Green Device Available
- Suit for 4.5V Gate Drive Applications

PPAK5X6 Dual Pin Configuration



Applications

- Battery Protection
- Load switch
- Uninterruptible Power Supply

Absolute Maximum Ratings T_c=25°C unless otherwise noted

Symbol	Parameter	Rating		Units
V _{DS}	Drain-Source Voltage	60	-60	V
V _{GS}	Gate-Source Voltage	±20	±20	V
I _D	Drain Current - Continuous (T _A =25°C)	6.06	-4.58	A
I _{DM}	Drain Current - Pulsed (NOTE 1)	24	-18	A
EAS	Single Pulse Avalanche Energy (NOTE 2 · 6)	25.5	35.3	mJ
IAS	Single Pulse Avalanche Current (NOTE 2)	22.6	-26.6	A
P _D	Power Dissipation (T _A =25°C)	1.47		W
T _J	Operating Junction Temperature Range	-55 to 150		°C
T _{STG}	Storage Temperature Range	-55 to 150		°C
Marking Code		BG040		

Thermal Characteristics

Symbol	Parameter	Rating	Unit
R _{θJA}	Thermal Resistance Junction to Ambient	85	°C/W



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N Channel Electrical Characteristics (T_J=25°C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	60	---	---	V
I _{DSS}	Drain-Source Leakage Current	V _{DS} =48V, V _{GS} =0V	---	---	1	uA
I _{GSS}	Gate-Source Leakage Current	V _{GS} =±20V, V _{DS} =0V	---	---	±100	nA

On Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =4A	---	---	40	mΩ
		V _{GS} =4.5V, I _D =2A	---	---	45	
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	1.2	---	2.5	V
g _{fs}	Forward Transconductance	V _{DS} =5V, I _D =4A	---	21	---	S

Dynamic and switching Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
Q _g	Total Gate Charge	V _{DS} =48V, V _{GS} =4.5V, I _D =4A	---	12.6	---	nC
Q _{gs}	Gate-Source Charge		---	3.2	---	
Q _{gd}	Gate-Drain Charge		---	6.3	---	
T _{d(on)}	Turn-On Delay Time	V _{DD} =30V, V _{GS} =10V, R _G =3.3Ω, I _D =4A	---	8	---	nS
T _r	Rise Time		---	14.2	---	
T _{d(off)}	Turn-Off Delay Time		---	24.4	---	
T _f	Fall Time		---	4.6	---	
C _{iss}	Input Capacitance	V _{DS} =15V, V _{GS} =0V, F=1MHz	---	1378	---	pF
C _{oss}	Output Capacitance		---	86	---	
C _{rss}	Reverse Transfer Capacitance		---	64	---	
R _g	Gate Resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	---	3.2	---	Ω

Drain-Source Diode Characteristics and Ratings

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I _S	Continuous Source Current	V _G =V _D =0V, Force Current	---	---	4.8	A
I _{SM}	Pulsed Source Current		---	---	9.6	A
V _{SD}	Diode Forward Voltage	V _{GS} =0V, I _S =1A	---	---	1.2	V

NOTES :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. V_{DD}=25V, V_{GS}=10V, L=0.1mH, I_{AS}=22.6A.
3. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%.
4. The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.



Characteristics Curves

FIG. 1-Output Characteristics

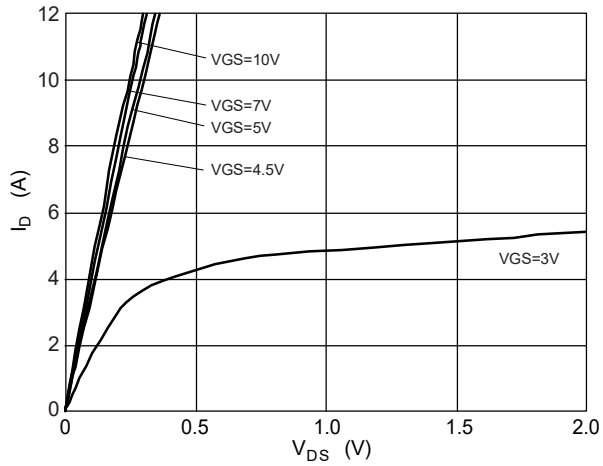


FIG. 2- $R_{DS(ON)}$ vs V_{GS}

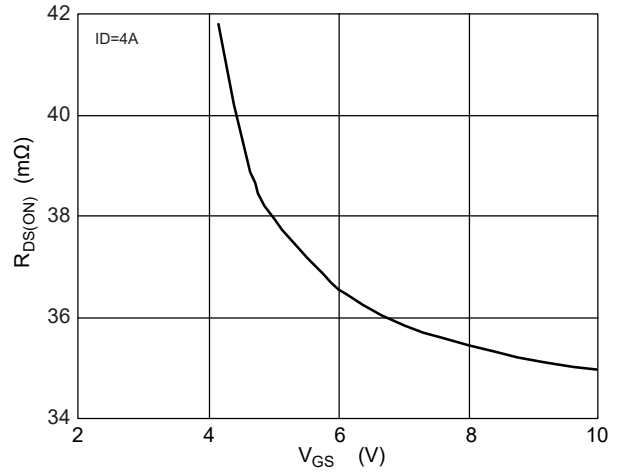


FIG. 3-Normalized V_{th} vs T_J

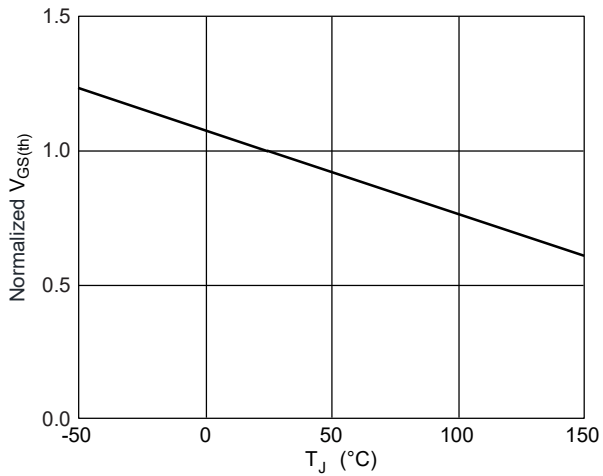


FIG. 4-Normalized $R_{DS(ON)}$ vs T_J

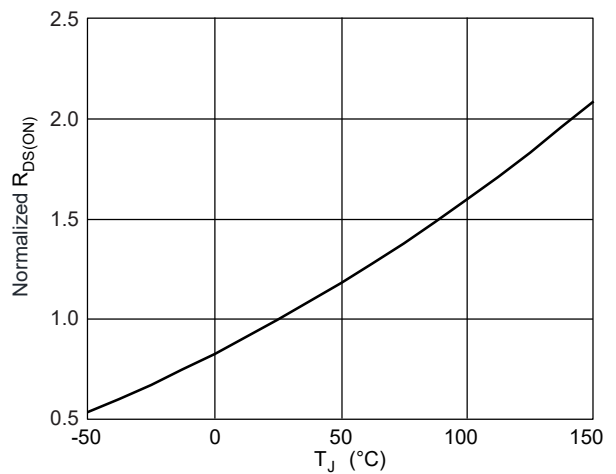


FIG. 5- I_S vs V_{SD}

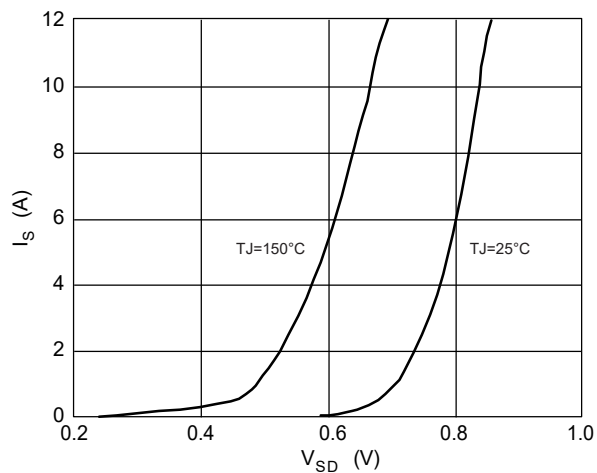
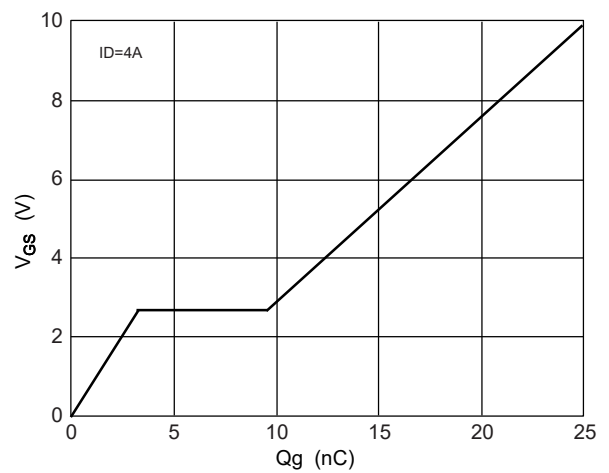


FIG. 6-Gate Charge Characteristics





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P Channel Electrical Characteristics (T_J=25°C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V , I _D = -250uA	-60	---	---	V
I _{DSS}	Drain-Source Leakage Current	V _{DS} = -48V , V _{GS} = 0V	---	---	-1	uA
I _{GSS}	Gate-Source Leakage Current	V _{GS} = ±20V , V _{DS} = 0V	---	---	±100	nA

On Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = -10V , I _D = -3A	---	---	70	mΩ
		V _{GS} = -4.5V , I _D = -2A	---	---	105	
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D = -250uA	-1.2	---	-2.5	V
g _{fs}	Forward Transconductance	V _{DS} = -5V , I _D = -3A	---	15	---	S

Dynamic and switching Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
Q _g	Total Gate Charge	V _{DS} = -48V , V _{GS} = -4.5V , I _D = -3A	---	9.86	---	nC
Q _{gs}	Gate-Source Charge		---	3.1	---	
Q _{gd}	Gate-Drain Charge		---	2.95	---	
T _{d(on)}	Turn-On Delay Time	V _{DD} = -15V , V _{GS} = -10V , R _G = 3.3Ω , I _D = -1A	---	28.8	---	nS
T _r	Rise Time		---	19.8	---	
T _{d(off)}	Turn-Off Delay Time		---	60.8	---	
T _f	Fall Time		---	7.2	---	
C _{iss}	Input Capacitance	V _{DS} = -15V , V _{GS} = 0V , F= 1MHz	---	1447	---	pF
C _{oss}	Output Capacitance		---	97.3	---	
C _{rss}	Reverse Transfer Capacitance		---	70	---	
R _g	Gate Resistance	V _{GS} =0V , V _{DS} =0V , F=1MHz	---	13.5	---	Ω

Drain-Source Diode Characteristics and Ratings

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I _S	Continuous Source Current	V _G =V _D =0V , Force Current	---	---	-3.7	A
I _{SM}	Pulsed Source Current		---	---	-7.5	A
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S = -1A	---	---	-1.2	V

NOTES :

5. Repetitive Rating : Pulsed width limited by maximum junction temperature.
6. V_{DD}=-25V, V_{GS}=-10V, L=0.1mH, I_{AS}=-26.6A.
7. The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
8. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



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Characteristics Curves

FIG. 7-Output Characteristics

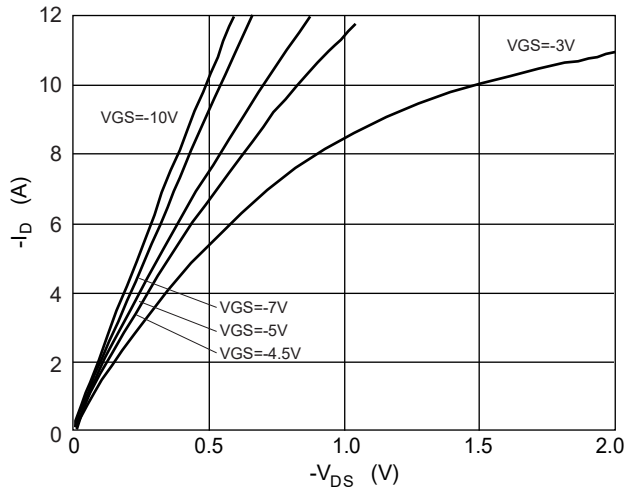


FIG. 8- $R_{DS(ON)}$ vs V_{GS}

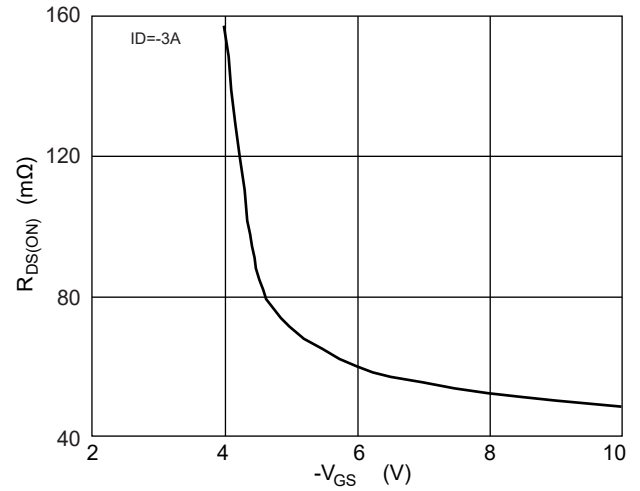


FIG. 9-Normalized V_{th} vs T_J

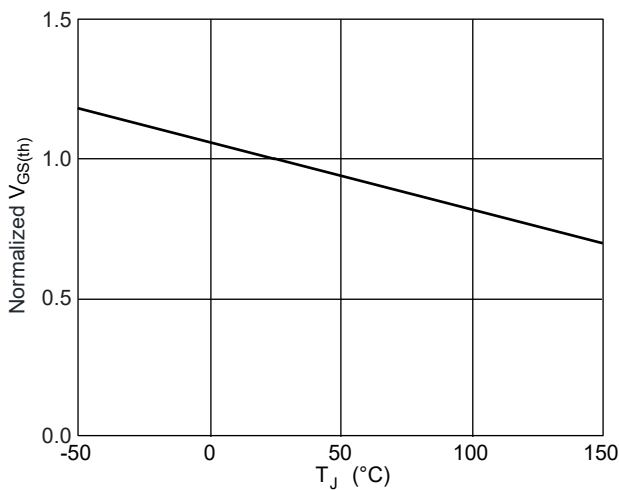


FIG. 10-Normalized $R_{DS(ON)}$ vs T_J

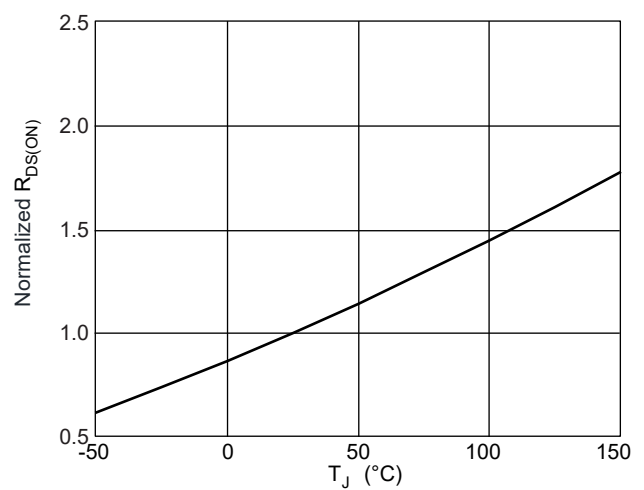


FIG. 11- I_S vs V_{SD}

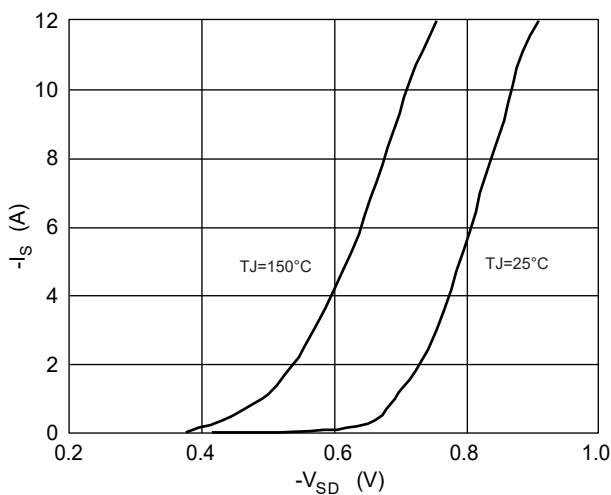
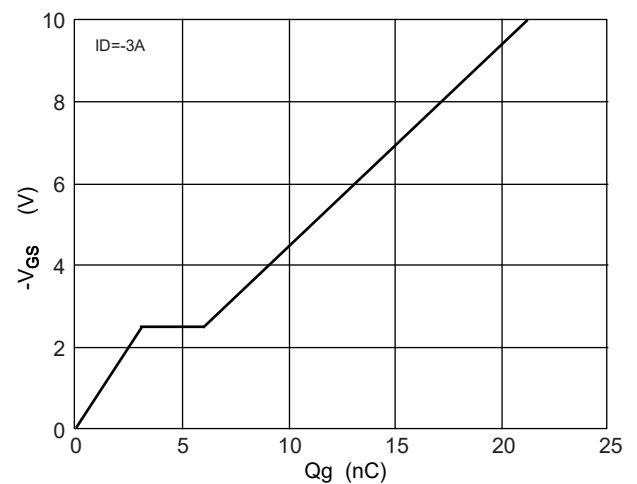


FIG. 12-Gate Charge Characteristics



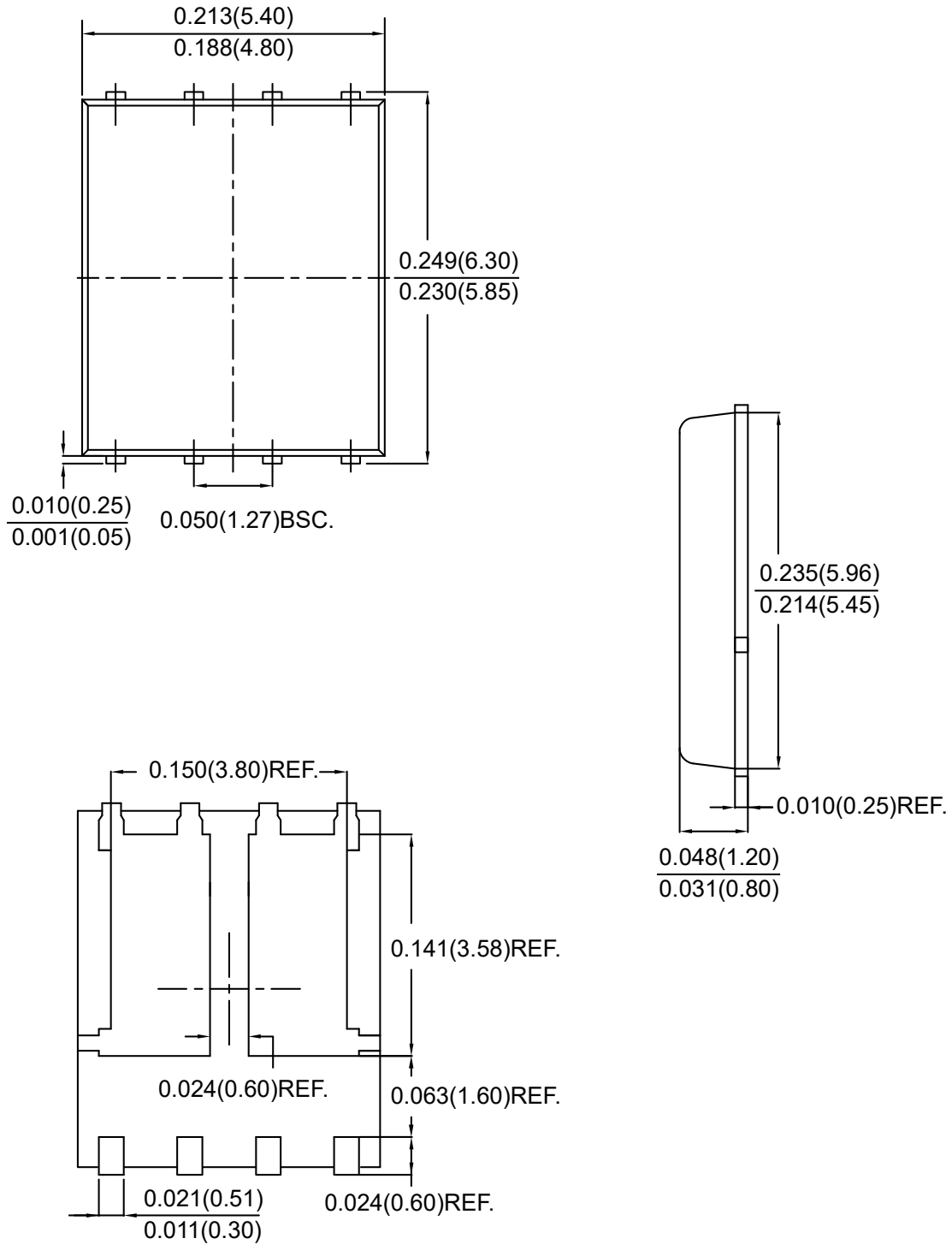


P5MBG040



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Package Outline Dimensions



PPAK5X6 Dual

Dimensions in inches and (millimeters)



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